

Date	User	Film	Recipe	Substrate T	Coat time	Dep.time	Thickness	JAW EC-400 (Woolam S.E.)			Index+1%	Index -1%	Dep.rate	Avg.dep. rate			HF e.r.	Stress	Avg Stress	Avg+10%	Avg-10%	LPD (light point defects)		Comment
								Index @632.8nm	Index @1550nm	Index @632.8nm				(nm/min)	(nm/min)	(nm/min)						(nm/min)	Mpa	
01/17/14	Biljana	SiO2	Oxide	300	10min	600.00	2855.83	1.472	1.461	1.473	1.488	1.458	28.56	27.88	28.72	27.04	493.56	-281.41	-273.21	-300.53	-245.88	166	329	Uniform film
01/29/14	Biljana	SiO2	Oxide	300	10min	600.00	2762.42	1.474	1.463	1.473	1.488	1.458	27.62	27.88	28.72	27.04		-273.21	-300.53	-245.88			Uniform film	
02/03/14	Biljana	SiO2	Oxide	300	10min	600.00	2772.81	1.473	1.462	1.473	1.488	1.458	27.73	27.88	28.72	27.04	576.43	-262.42	-273.21	-300.53	-245.88	116	285	Uniform film
02/18/14	Biljana	SiO2	Oxide	300	10min	600.00	2772.60	1.473	1.462	1.473	1.488	1.458	27.73	27.88	28.72	27.04	574.32	-265.31	-273.21	-300.53	-245.88	29	137	Uniform film
03/12/14	Biljana	SiO2	Oxide	300	10min	600.00	2776.83	1.473	1.462	1.473	1.488	1.458	27.77	27.88	28.72	27.04	544.14	-283.68	-273.21	-300.53	-245.88	87	115	Uniform film

Avg Thickness	2788.10	Avg Index	1.473	Avg.dep.rate	27.88	Avg HF e.r.	548.10
		Index+1%	1.488	Avg+3%	28.72	Avg Stress	-273.21
		Index-1%	1.458	Avg-3%	27.04	Avg+10%	-300.53
						Avg-10%	-245.88

